Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/797,112	TSUCHIYA ET AL.	
Examiner	Art Unit	
Bao Q. Vu	2838	

	SEAR	CHED	
Class	Subclass	Date	Examiner
361	698	5/27/2005	BV
-	699		
	702		
	710		
257	711		
	714		
165	80.4		

INT	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner
361	698	5/27/2005	BV
	702		
	710		

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